# ICS851S201I

# 2:1 Differential-to-HCSL Multiplexer with Low Input Level Alarm

### DATASHEET

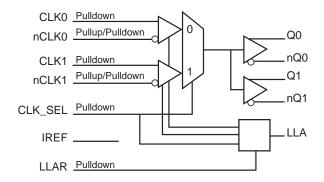
### **General Description**

The ICS851S201I is a high performance 2:1 Differential-to-HCSL Multiplexer with a 2 output fanout buffer. The ICS851S201I operates up to 250MHz and accepts HCSL and other low level differential inputs levels. Input level detection circuitry is available to flag input levels that drops below a specified value and on the selected input. This signal is latched until the status is reset via the alarm reset input. The ICS851S201I is packaged in a small 3mm x 3mm 16 lead VFQFN package, making it ideal for use on space constrained boards.

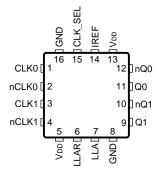
### **Features**

- Two differential HCSL output pairs
- Two selectable differential clock input pairs
- · CLKx, nCLKx pairs can accept HCSL level inputs
- Low level input detection on selected input (latched)
- Maximum Input frequency: 250MHz
- Output skew: 5ps (typical)
- Propagation delay: 1.4ns (typical)
- Additive RMS phase jitter at 133.33MHz (12kHz 20MHz): 0.151ps (typical)
- Full 3.3V operating supply
- -40°C to 85°C ambient operating temperature
- Lead-free (RoHS 6) packaging

# **Block Diagram**



# **Pin Assignment**



ICS851S201I

16-Lead VFQFN Top View

# **Pin Descriptions and Characteristics**

### Table 1. Pin Descriptions

Number	Name	Ту	/pe	Description
1	CLK0	Input	Pulldown	Non-inverting differential HCSL clock input.
2	nCLK0	Input	Pullup/ Pulldown	Inverting differential HCSL clock input. V <sub>DD</sub> /2 default when left floating.
3	CLK1	Input	Pulldown	Non-inverting differential HCSL clock input.
4	nCLK1	Input	Pullup/ Pulldown	Inverting differential HCSL clock input. V <sub>DD</sub> /2 default when left floating.
5, 13	V <sub>DD</sub>	Power		Positive supply pins.
6	LLAR	Input	Pulldown	Low Level Alarm Reset. When HIGH, resets LLA latch. Must be LOW to allow LLA to set. LVCMOS/LVTTL interface levels.
7	LLA	Output		Low Level Alarm. When HIGH, low level input has been detected on selected differential input (latched).
8, 16	GND	Power		Power supply ground.
9, 10	Q1, nQ1	Output		Differential output pair. HCSL interface levels.
11, 12	Q0, nQ0	Output		Differential output pair. HCSL interface levels.
14	IREF	Input		External fixed precision resistor $(475\Omega)$ from this pin to ground provides a reference current used for differential current-mode Qx, nQx clock outputs.
15	CLK_SEL	Input	Pulldown	Clock select input. When HIGH, selects CLK1, nCLK1 inputs. When LOW, selects CLK0, nCLK0 inputs. LVCMOS/LVTTL interface levels.

NOTE: Pullup and Pulldown refer to internal input resistors. See Table 2, Pin Characteristics, for typical values.

#### Table 2. Pin Characteristics

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
C <sub>IN</sub>	Input Capacitance			2		рF
R <sub>PULLDOWN</sub>	Input Pulldown Resistor			50		kΩ
R <sub>PULLUP</sub>	Input Pullup Resistor			50		kΩ

# **Function Tables**

Table 3A. Low Level Alarm Function Table

Valid Input Level on Selected Input	LLAR	LLA
$V_{IH} \ge 550 mV$	0	LOW (default)
$V_{IH} \le 325 mV$	0	HIGH
n/a	1	Forced LOW

NOTE: Input amplitude that is <550mV and >325mV will not reliably cause the LLA output to go HIGH. Input amplitude that is <325mV will always flag the LLA output HIGH.

NOTE: Logic High, logic Low, and a differential short on the inputs will cause the LLA output to go HIGH. This feature is only available when both differential inputs are being used, and their respective frequencies are within ±50% of one another (i.e.: CLK0 is 100MHz, CLK1 must be within 50MHz to 150MHz).

#### Table 3B. Control Input Function Table

CLK_SEL	Input Selected
0	CLK0, nCLK0 (default)
1	CLK1, nCLK1

# **Absolute Maximum Ratings**

NOTE: Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These ratings are stress specifications only. Functional operation of product at these conditions or any conditions beyond those listed in the *DC Characteristics or AC Characteristics* is not implied. Exposure to absolute maximum rating conditions for extended periods may affect product reliability.

Item	Rating
Supply Voltage, V <sub>DD</sub>	4.6V
Inputs, V <sub>I</sub>	-0.5V to V <sub>DD</sub> + 0.5V
Outputs, V <sub>O</sub>	-0.5V to V <sub>DD</sub> + 0.5V
Package Thermal Impedance, $\theta_{JA}$	74.7°C/W (0 mps)
Storage Temperature, T <sub>STG</sub>	-65°C to 150°C

# **DC Electrical Characteristics**

#### Table 4A. Power Supply DC Characteristics, $V_{DD}$ = 3.3V±5%; $T_A$ = -40°C to 85°C

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
V <sub>DD</sub>	Positive Supply Voltage		3.135	3.3	3.465	V
I <sub>DD</sub>	Power Supply Current	unloaded outputs			44	mA

#### **Table 4B. LVCMOS/LVTTL DC Characteristics,** V<sub>DD</sub> = 3.3V±5%; T<sub>A</sub> = -40°C to 85°C

Symbol	Parameter		Test Conditions	Minimum	Typical	Maximum	Units
V <sub>IH</sub>	Input High Vo	oltage		2.2		V <sub>DD</sub> + 0.3	V
V <sub>IL</sub>	Input Low Vo	Itage		-0.3		0.8	V
IIH	Input High Current	LLAR, CLK_SEL	V <sub>DD</sub> = V <sub>IN</sub> = 3.465V			150	μA
IIL	Input Low Current	LLAR, CLK_SEL	V <sub>DD</sub> = 3.465V, V <sub>IN</sub> = 0V	-10			μA
V <sub>OH</sub>	Output High Voltage	LLA; NOTE 1		2.6			V
V <sub>OL</sub>	Output Low Voltage	LLA; NOTE 1				0.5	V

NOTE 1: See Parameter Measurement Information Section, 3.3V Output Load Test Circuit diagram.

#### Table 4C. DC Characteristics, $V_{DD}$ = 3.3V±5%; $T_A$ = -40°C to 85°C

Symbol	Parameter		Test Conditions	Minimum	Typical	Maximum	Units
IIH	Input High Current	CLK0, CLK1, nCLK0, nCLK1	V <sub>DD</sub> = V <sub>IN</sub> = 3.465V			150	μA
	Input Low	CLK0, CLK1	V <sub>DD</sub> = 3.465V, V <sub>IN</sub> = 0V	-10			μA
I <sub>IL</sub>	Current	nCLK0, nCLK1	V <sub>DD</sub> = 3.465V, V <sub>IN</sub> = 0V	-150			μA
V <sub>PP</sub>	Peak-to-Peal	< Voltage		150		1300	mV
V <sub>CMR</sub>	Common Mo NOTE 1	de Input Voltage;		GND – 0.5		V <sub>DD</sub> – 0.85	v

NOTE 1: Common mode input voltage is defined at the cross point.

# **AC Electrical Characteristics**

Table 5. AC Characteristics,  $V_{DD} = 3.3V \pm 5\%$ ;  $T_A = -40^{\circ}C$  to  $85^{\circ}C$ 

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
f <sub>OUT</sub>	Output Frequency				250	MHz
t <sub>PD</sub>	Propagation Delay; NOTE 1		1.24	1.4	1.70	ns
<i>t</i> sk(pp)	Part-to-Part Skew; NOTE 2, 3				150	ps
tsk(o)	Output Skew, Note 2, 4			5	34	ps
tjit	Buffer Additive Phase Jitter, RMS	133.33MHz, Integration Range: 12kHz - 20MHz		0.151	0.166	ps
	Rise/Fall Edge Rate; NOTE 5, 6		1.60	2.56	3.74	V/ns
V <sub>MAX</sub>	Absolute Max Output Voltage; NOTE 7, 8				1150	mV
V <sub>MIN</sub>	Absolute Min Output Voltage NOTE 7, 9		-300			mV
V <sub>CROSS</sub>	Absolute Crossing Voltage; NOTE 7, 10, 11		250		550	mV
$\Delta V_{CROSS}$	Total Variation of V <sub>CROSS</sub> over all edges; NOTE 7, 10, 12				140	mV
odc	Output Duty Cycle		47	50	53	%
MUXISOL	MUX Isolation; NOTE 13	$f_{OUT} = 100 MHz$	-65	-63	-62	dB

NOTE: Electrical parameters are guaranteed over the specified ambient operating temperature range, which is established when the device is mounted in a test socket with maintained transverse airflow greater than 500 lfpm. The device will meet specifications after thermal equilibrium has been reached under these conditions.

NOTE: All parameters measured at  $f \leq$  250MHz unless otherwise noted.

NOTE 1: Measured from the differential input crossing point to the differential output crossing point.

NOTE 2: This parameter is defined in accordance with JEDEC Standard 65.

NOTE 3: Defined as skew between outputs on different devices operating at the same supply voltage, same temperature, same frequency and with equal load conditions. Using the same type of inputs on each device, the outputs are measured at the differential cross points. NOTE 4: Defined as skew between outputs at the same supply voltages and with equal load conditions. Measured at the output differential cross points.

NOTE 5: Measurement taken from differential waveform.

NOTE 6: Measured from -150mV to +150mV on the differential waveform (derived from Qx minus nQx). The signal must be monotonic through the measurement region for rise and fall time. The 300mV measurement window is centered on the differential zero crossing. See Parameter Measurement Information Section.

NOTE 7: Measurement taken from single ended waveform.

NOTE 8: Defined as the maximum instantaneous voltage including overshoot. See Parameter Measurement Information Section.

NOTE 9: Defined as the minimum instantaneous voltage including undershoot. See Parameter Measurement Information Section.

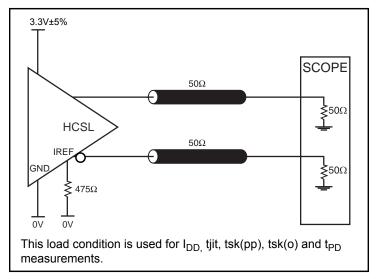
NOTE 10: Measured at crossing point where the instantaneous voltage value of the rising edge of Qx equals the falling edge of nQx. See Parameter Measurement Information Section

NOTE 11: Refers to the total variation from the lowest crossing point to the highest, regardless of which edge is crossing. Refers to all crossing points for this measurement. See Parameter Measurement Information Section.

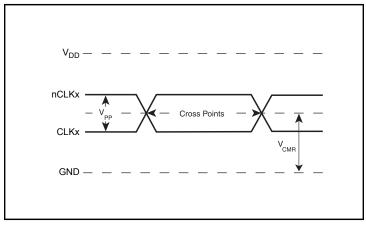
NOTE 12: Defined as the total variation of all crossing voltage of rising Qx and falling nQx. This is the maximum allowed variance in the  $V_{CROSS}$  for any particular system. See Parameter Measurement Information Section.

NOTE 13: Qx, nQx output measured differentially. See Parameter Measurement Information for MUX Isolation diagram.

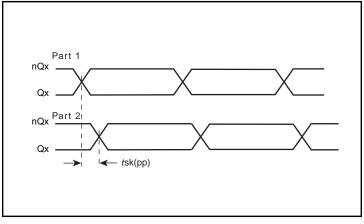
### **Parameter Measurement Information**



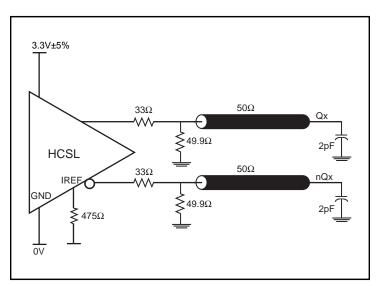




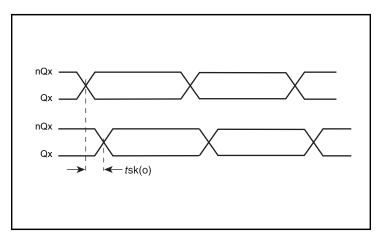
**Differential Input Level** 



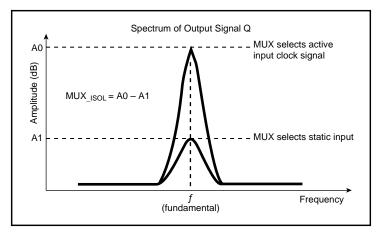
Part-to-Part Skew



**Output Load AC Test Circuit** 

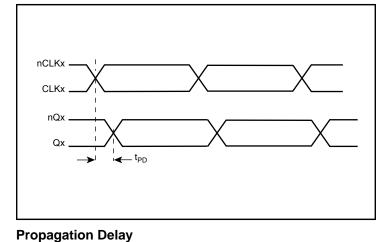


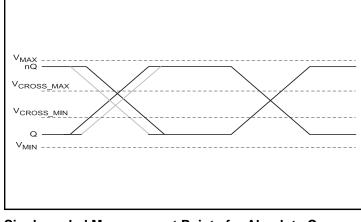




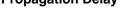


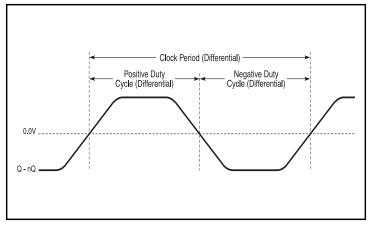
### Parameter Measurement Information, continued



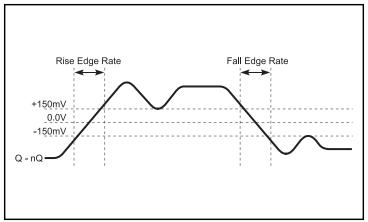


Single-ended Measurement Points for Absolute Cross Point and Swing

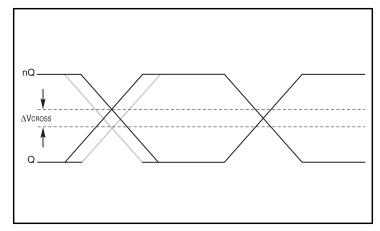




**Differential Measurement Points for Duty Cycle/Period** 



**Output Rise/Fall Edge Rate** 



**Single-ended Measurement Points for Delta Cross Point** 

# **Applications Information**

### **Recommendations for Unused Input and Output Pins**

#### Inputs:

#### **CLK/nCLK Inputs**

For applications not requiring the use of a differential input, both the CLK and nCLK pins can be left floating. Though not required, but for additional protection, a  $1k\Omega$  resistor can be tied from CLK to ground.

#### **LVCMOS Control Pins**

All control pins have internal pulldowns; additional resistance is not required but can be added for additional protection. A  $1k\Omega$  resistor can be used.

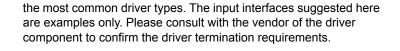
### Outputs:

#### **Differential Outputs**

All unused differential outputs can be left floating. We recommend that there is no trace attached. Both sides of the differential output pair should either be left floating or terminated.

### **Differential Clock Input Interface**

The CLK /nCLK accepts HCSL and other differential signals. Both differential signals must meet the V<sub>PP</sub> and V<sub>CMR</sub> input requirements. *Figure 2* shows interface examples for the CLK/nCLK input driven by



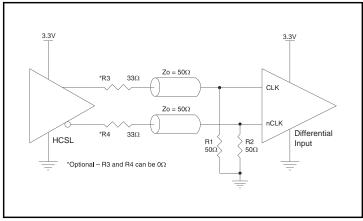


Figure 2. CLK/nCLK Input Driven by a 3.3V HCSL Driver

### **VFQFN EPAD Thermal Release Path**

In order to maximize both the removal of heat from the package and the electrical performance, a land pattern must be incorporated on the Printed Circuit Board (PCB) within the footprint of the package corresponding to the exposed metal pad or exposed heat slug on the package, as shown in *Figure 3*. The solderable area on the PCB, as defined by the solder mask, should be at least the same size/shape as the exposed pad/slug area on the package to maximize the thermal/electrical performance. Sufficient clearance should be designed on the PCB between the outer edges of the land pattern and the inner edges of pad pattern for the leads to avoid any shorts.

While the land pattern on the PCB provides a means of heat transfer and electrical grounding from the package to the board through a solder joint, thermal vias are necessary to effectively conduct from the surface of the PCB to the ground plane(s). The land pattern must be connected to ground through these vias. The vias act as "heat pipes". The number of vias (i.e. "heat pipes") are application specific and dependent upon the package power dissipation as well as electrical conductivity requirements. Thus, thermal and electrical analysis and/or testing are recommended to determine the minimum number needed. Maximum thermal and electrical performance is achieved when an array of vias is incorporated in the land pattern. It is recommended to use as many vias connected to ground as possible. It is also recommended that the via diameter should be 12 to 13mils (0.30 to 0.33mm) with 1oz copper via barrel plating. This is desirable to avoid any solder wicking inside the via during the soldering process which may result in voids in solder between the exposed pad/slug and the thermal land. Precautions should be taken to eliminate any solder voids between the exposed heat slug and the land pattern. Note: These recommendations are to be used as a guideline only. For further information, please refer to the Application Note on the Surface Mount Assembly of Amkor's Thermally/ Electrically Enhance Leadframe Base Package, Amkor Technology.

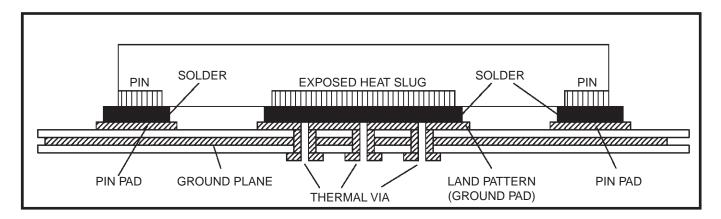


Figure 3. P.C. Assembly for Exposed Pad Thermal Release Path - Side View (drawing not to scale)

### **Recommended Termination**

*Figure 4A* is the recommended source termination for applications where the driver and receiver will be on a separate PCBs. This termination is the standard for PCI Express<sup>™</sup> and HCSL output

types. All traces should be  $50\Omega$  impedance single-ended or  $100\Omega$  differential.

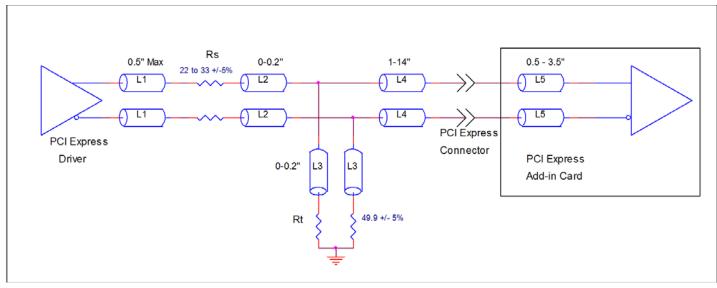


Figure 4A. Recommended Source Termination (where the driver and receiver will be on separate PCBs)

*Figure 4B* is the recommended termination for applications where a point-to-point connection can be used. A point-to-point connection contains both the driver and the receiver on the same PCB. With a matched termination at the receiver, transmission-line reflections will

be minimized. In addition, a series resistor (Rs) at the driver offers flexibility and can help dampen unwanted reflections. The optional resistor can range from  $0\Omega$  to  $33\Omega$ . All traces should be  $50\Omega$  impedance single-ended or  $100\Omega$  differential.

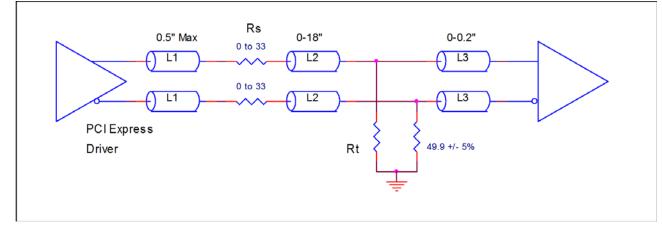


Figure 4B. Recommended Termination (where a point-to-point connection can be used)

### **Power Considerations**

This section provides information on power dissipation and junction temperature for the ICS851S201I. Equations and example calculations are also provided.

#### 1. Power Dissipation.

The total power dissipation for the ICS851S201I is the sum of the core power plus the power dissipated in the load(s). The following is the power dissipation for  $V_{DD}$  = 3.3V + 5% = 3.465V, which gives worst case results.

NOTE: Please refer to Section 3 for details on calculating power dissipated in the load.

The maximum current at 85°C is as follows:

 $I_{DD_{MAX}} = 37mA$ 

- Power (core)<sub>MAX</sub> = V<sub>DD\_MAX</sub> \* I<sub>DD</sub> = 3.465V \* 44mA = **152.46mW**
- Power (HCSL)<sub>MAX</sub> = 2 \* 44.5mW = 89mW

Total Power\_MAX = 152.46mW + 89mW = 241.46mW

#### 2. Junction Temperature.

Junction temperature, Tj, is the temperature at the junction of the bond wire and bond pad directly affects the reliability of the device. The maximum recommended junction temperature is 125°C. Limiting the internal transistor junction temperature, Tj, to 125°C ensures that the bond wire and bond pad temperature remains below 125°C.

The equation for Tj is as follows: Tj =  $\theta_{JA}$  \* Pd\_total + T<sub>A</sub>

Tj = Junction Temperature

 $\theta_{JA}$  = Junction-to-Ambient Thermal Resistance

Pd\_total = Total Device Power Dissipation (example calculation is in section 1 above)

T<sub>A</sub> = Ambient Temperature

In order to calculate junction temperature, the appropriate junction-to-ambient thermal resistance  $\theta_{JA}$  must be used. Assuming no air flow and a multi-layer board, the appropriate value is 74.7°C/W per Table 7 below.

Therefore, Tj for an ambient temperature of 85°C with all outputs switching is:

 $85^{\circ}$ C + 0.242W \* 74.7°C/W = 103°C. This is below the limit of 125°C.

This calculation is only an example. Tj will obviously vary depending on the number of loaded outputs, supply voltage, air flow and the type of board (multi-layer).

#### Table 6. Thermal Resistance $\theta_{\text{JA}}$ for 16 Lead VFQFN, Forced Convection

$\theta_{JA}$ vs. Air Flow					
Meters per Second	0	1	2.5		
Multi-Layer PCB, JEDEC Standard Test Boards	74.7°C/W	65.3°C/W	58.5°C/W		

#### 3. Calculations and Equations.

The purpose of this section is to calculate power dissipation on the IC per HCSL output pair.

HCSL output driver circuit and termination are shown in Figure 6.

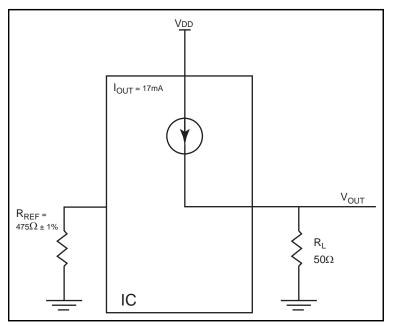


Figure 6. HCSL Driver Circuit and Termination

HCSL is a current steering output which sources a maximum of 17mA of current per output. To calculate worst case on-chip power dissipation, use the following equations which assume a  $50\Omega$  load to ground.

The highest power dissipation occurs when  $V_{DD\_MAX}$ .

```
Power = (V_{DD\_MAX} - V_{OUT}) * I_{OUT}
since V_{OUT} = I_{OUT} * R_L
Power = (V_{DD\_MAX} - I_{OUT} * R_L) * I_{OUT}
= (3.465V - 17mA * 50\Omega) * 17mA
```

Total Power Dissipation per output pair = 44.5mW

### **Reliability Information**

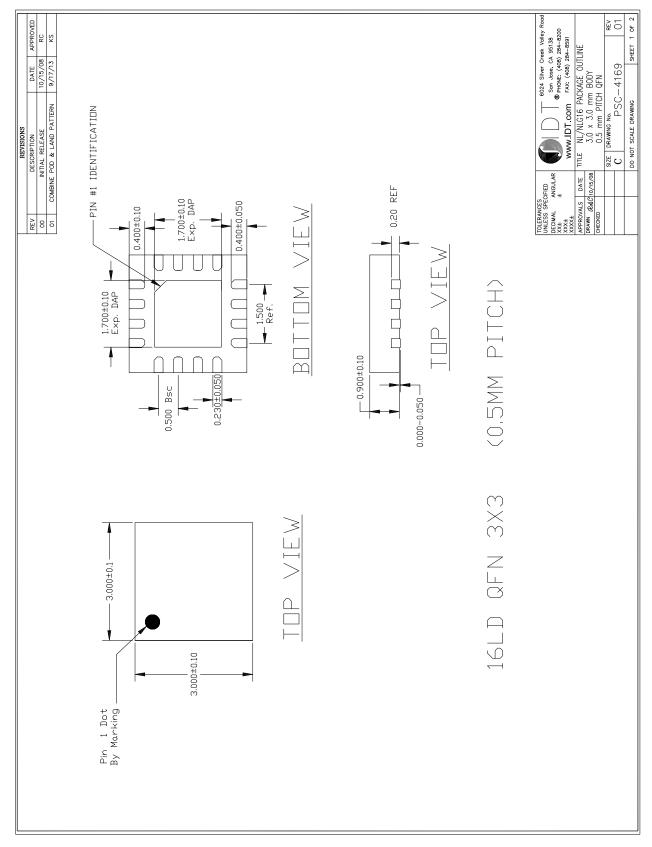
Table 7.  $\theta_{\text{JA}}$  vs. Air Flow Table for a 16 Lead VFQFN

θ <sub>JA</sub> by Velocity					
Meters per Second	0	1	2.5		
Multi-Layer PCB, JEDEC Standard Test Boards	74.7°C/W	65.3°C/W	58.5°C/W		

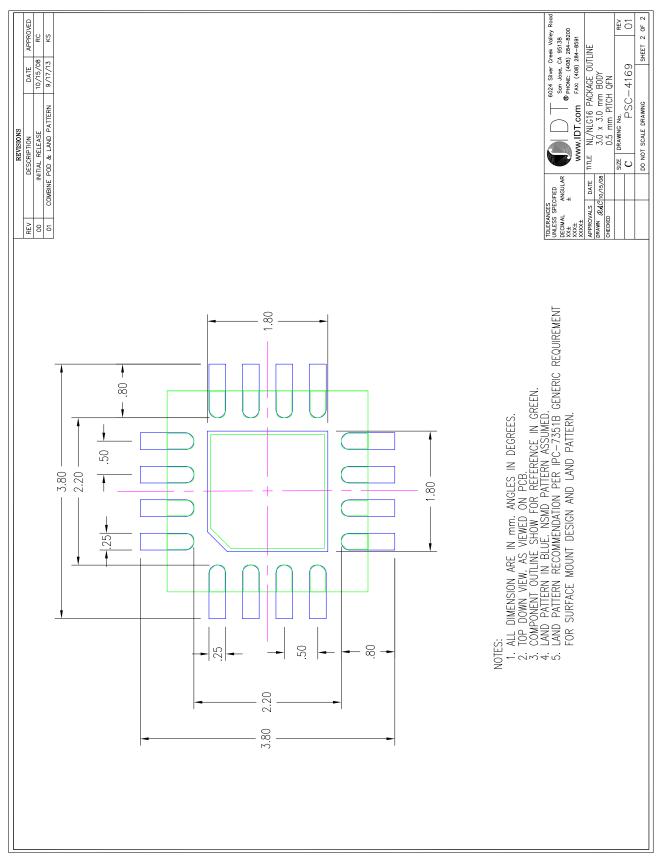
### **Transistor Count**

The transistor count for ICS851S201I is: 713

# Package Outline Drawings (Sheet 1)







# **Ordering Information**

### Table 9. Ordering Information

Part/Order Number	Marking	Package	Shipping Packaging	Temperature
851S201CKILF	1CIL	"Lead-Free" 16 Lead VFQFN	Tube	-40°C to 85°C
851S201CKILFT	1CIL	"Lead-Free" 16 Lead VFQFN	Tape & Reel	-40°C to 85°C

### **Revision History Sheet**

Rev	Table	Page	Description of Change	Date
A	AMR T4B T5 T5	4 4 5 5	Supply Voltage, $V_{DD}$ = 4.6V. Note 1: Deleted 'Outputs terminated with 50 $\Omega$ to VDD/2.'. Output Duty Cycle: 47%(Min), 53%(Max). MUX <sub>ISOL</sub> : -65dB (Min)	9/62013
В	-	14	Updated the package outline drawings.	5/27/2017



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